

AP20 Rec'd PCT/PTO 02 AUG 2006

PATENT APPLICATION

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Application of

Naoyuki KOBAYASHI et al.

Application No.: New U.S. National Phase of
PCT/JP2005/001990

Filed: August 2, 2006

Docket No.: 128977

For: EXPOSURE APPARATUS, EXPOSURE METHOD, AND METHOD FOR PRODUCING
DEVICEINFORMATION DISCLOSURE STATEMENTCommissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to 37 CFR §1.56, the attention of the Patent and Trademark Office is hereby directed to the references listed on the attached PTO-1449. Unless otherwise indicated herein, one copy of each reference is attached. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that the references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.

- 1. This Information Disclosure Statement is being filed (a) within three months of the U.S. filing date of this non-CPA application, OR (b) before the mailing date of a first Office Action on the merits in the present application. No certification or fee is required.
- 2. One or more reference cited herein was cited in the International Search Report. A copy of the International Search Report is attached for the Examiner's information. See References 9, 10, and 12 - 15.
- 3. In accordance with 37 CFR §1.98(a)(2)(ii), copies of any U.S. patents and patent application publications are not attached.
- 4. An English language Abstract of one or more non-English language reference is attached hereto. See References 9, 10, 12 - 19 and 23 - 31.
- 5. A computer-generated English language translation of one or more Japanese Patent Publication cited herein has been obtained from the website of the Japanese Patent Office ([<http://www.jpo.go.jp>]), and is attached, but has not been reviewed for accuracy. See References 9, 12 - 15, 17 - 19 and 25 - 27.

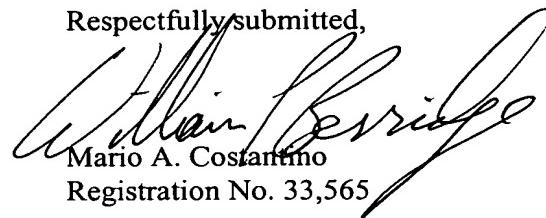
10/588297

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- 6. References 3 and 11 correspond to reference 12. Reference 1 corresponds to reference 14. Reference 2 corresponds to reference 15.
- 7. An English language translation of one or more references cited herein is attached. See References 10, 21, 22 and 28.

Respectfully submitted,



Mario A. Costantino
Registration No. 33,565

William P. Berridge
Registration No. 30,024

MAC:WPB/jtp

Date: August 2, 2006

OLIFF & BERRIDGE, PLC
P.O. Box 19928
Alexandria, Virginia 22320
Telephone: (703) 836-6400

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Form PTO-1449 (REV. 1/06)		US Dept. of Commerce PATENT & TRADEMARK OFFICE	ATTY DOCKET NO. 128977	107588297 APPLICATION NUMBER New U.S. National Phase of PCT/JP2005/001990
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)		APPLICANTS Naoyuki KOBAYASHI et al.		
		FILING DATE August 2, 2006		

U.S. PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Name
	1	2002/0063856 A1	5/30/2002	INOUE
	2	2005/0046813 A1	3/3/2005	STREEFKERK et al.
	3	5,825,043	10/20/1998	SUWA
	4	4,346,164	8/24/1982	TABARELLI et al.
	5	4,480,910	11/6/1984	TAKANASHI et al.
	6	5,715,039	2/3/1998	FUKUDA et al.
	7	2004/0165159 A1	8/26/2004	LOF et al.
	8	5,610,683	3/11/1997	TAKAHASHI

FOREIGN PATENT DOCUMENTS

Examiner Initials	Cite No.	Document Number	Date	Country	With English Abstract	With English Translation
	9	JP A 10-303114	11/13/1998	Japan	X	X
	10	WO 99/49504	9/30/1999	WIPO	X	X
	11	EP 0 834 773 A2	4/8/1998	Europe		
	12	JP A 10-154659	6/9/1998	Japan	X	X
	13	JP A 9-232213	9/5/1997	Japan	X	X
	14	JP A 2002-231622	8/16/2002	Japan	X	X
	15	JP A 2005-51231	2/24/2005	Japan	X	X
	16	JP A 4-305917	10/28/1992	Japan	X	
	17	JP A 10-340846	12/22/1998	Japan	X	X
	18	JP A 11-176727	7/2/1999	Japan	X	X
	19	JP A 2000-58436	2/25/2000	Japan	X	X
	20	WO 2004/019128 A2	3/4/2004	WIPO		
	21	DD 221 563 A1	4/24/1985	Germany		X
	22	DD 224 448 A1	7/3/1985	Germany		X

OTHER DOCUMENTS

Examiner Initials	Cite No.	(Including Author, Title, Date, Pertinent Pages, etc.)

EXAMINER	DATE CONSIDERED
Examiner: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.	

Date: August 2, 2006

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FOREIGN PATENT DOCUMENTS

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	23	JP A 58-202448	11/25/1983	Japan	X	
	24	JP A 62-65326	3/24/1987	Japan	X	
	25	JP A 5-62877	3/12/1993	Japan	X	X
	26	JP A 7-220990	8/18/1995	Japan	X	X
	27	JP A 8-316125	11/29/1996	Japan	X	X
	28	JP A 6-124873	5/6/1994	Japan	X	X
	29	JP A 59-19912	2/1/1984	Japan	X	
	30	JP A 4-305915	10/28/1992	Japan	X	
	31	JP A 63-157419	6/30/1988	Japan	X	

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